# Low Voltage SPDT Mux / Demux Analog Switch

The NLAS3157 Mux / Demux Analog Switch is an advanced high–speed single–pole double–throw (SPDT) CMOS switch. It can be used as an analog switch or as a low–delay bus switch. Break–before–make switching prevents both switches being enabled simultaneously. This eliminates signal disruption during switching. The control input, S, is independent of supply voltage line switch in an ultra–small footprint.

#### **Features**

- High Speed:  $t_{PD} = 0.25 \text{ ns (Max)} @ V_{CC} = 4.5 \text{ V}$
- $R_{ON}$ : 8.5  $\Omega$  Typ @  $V_{CC} = 4.2 \text{ V}$
- $C_{ON}$ : 7.5 pF Typ @  $V_{CC} = 3.3 \text{ V}$
- V<sub>CC</sub> Range: 1.65 V to 4.5 V
- Ultra-Small 1 x 1 mm Package
- This Device is Pb–Free, Halogen Free/BFR Free and RoHS Compliant

# **Typical Applications**

• Mobile Phones, PDAs, Camera

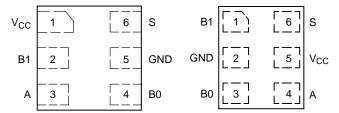
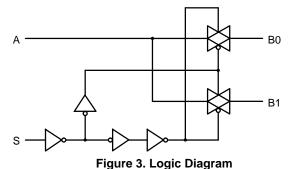


Figure 1. ULLGA6 (NLAS3157) (Top View)

Figure 2. XLLGA6 (NLAS3257) (Top View)





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# MARKING DIAGRAMS



ULLGA6 1.0 x 1.0 CASE 613AD



Y = Specific Device CodeM = Date Code



XLLGA6 1.0 x 1.0 CASE 713AD



L = Specific Device CodeM = Date Code

## **FUNCTION TABLE**

Input S	Function
L	A = B0
Н	A = B1

#### ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

**Table 1. MAXIMUM RATINGS** 

Symbol	Parameter	Value	Unit
V <sub>CC</sub>	DC Supply Voltage	-0.5 to +5.5	V
V <sub>IN</sub>	Control Input Voltage (S Pin)	-0.5 to +5.5	V
V <sub>IS</sub>	Switch Input / Output Voltage (A, BO, B1 Pins)	-0.5 to V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Control DC Input Diode Current (S Pin) V <sub>IN</sub> < GND	-50	mA
I <sub>OK</sub>	Switch I/O Port DC Diode Current (A, BO, B1 Pins) $V_{I/O} < GND \text{ or } V_{I/O} > V_{CC}$	±50	mA
Io	On-State Switch Current	±128	mA
	Continuous Current Through V <sub>CC</sub> or GND	±150	mA
Icc	DC Supply Current per Supply Pin	±150	mA
I <sub>GND</sub>	DC Ground Current per Ground Pin	±150	mA
T <sub>STG</sub>	Storage Temperature Range	-65 to +150	°C
TL	Lead Temperature, 1 mm from Case for 10 Seconds	260	°C
TJ	Junction Temperature Under Bias	150	°C
$\theta_{\sf JA}$	Thermal Resistance (Note 1)	407	°C/W
$P_{D}$	Power Dissipation in Still Air at 85°C (Note 1)	1.5	mW
MSL	Moisture Sensitivity	Level 1	
F <sub>R</sub>	Flammability Rating Oxygen Index: 28 to 34	UL 94 V-0 @ 0.125 in	
V <sub>ESD</sub>	ESD Withstand Voltage  Human Body Mode (Note 2)  Machine Mode (Note 3)  Charged Device Mode (Note 4)	>8000 >300 >2000	V
I <sub>LATCHUP</sub>	Latchup Performance Above V <sub>CC</sub> and Below GND at 85°C (Note 5)	±100	mA

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Measured with minimum pad spacing on an FR4 board, using 10 mm-by-1 inch, 2 ounce copper trace no air flow.
- 2. Tested to EIA/ JESD22-A114-A
- 3. Tested to EIA/ JESD22-A115-A
- 4. Tested to JESD22-C101-A
- 5. Tested to EIA / JESD78

# **Table 2. RECOMMENDED OPERATING CONDITIONS**

Symbol	Parameter	Min	Max	Unit
V <sub>CC</sub>	Positive DC Supply Voltage	1.65	4.5	V
VI	Control Input Voltage (S Pin)	0	4.5	V
V <sub>IS</sub>	Switch Input / Output Voltage (A, BO, B1 Pins)	0	V <sub>CC</sub>	V
T <sub>A</sub>	Operating Free–Air Temperature	-40	+85	°C
Δt / ΔV	Input Transition Rise or Fall Rate  Control Input Switch I/O	0 0	5 DC	ns/V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Table 3. DC ELECTRICAL CHARACTERISTICS (Typical: T = 25°C,  $V_{CC} = 3.3 \text{ V}$ )

				-40°C to +85°C			
Symbol	Parameter	Test Conditions	V <sub>CC</sub> (V)	Min	Тур	Max	Unit
V <sub>IH</sub>	Control Input, HIGH Voltage		1.65 2.7 3.3 4.2	0.75 1.25 1.52 1.94			V
V <sub>IL</sub>	Control Input, LOW Voltage		1.65 2.7 3.3 4.2			0.25 0.4 0.4 0.5	V
I <sub>IN</sub>	Control Input, Leakage Current	$0 \le V_{IS} \le V_{CC}$	1.65 – 4.5			±1.0	μΑ
I <sub>CC</sub>	Quiescent Supply Current	$V_{IS} = V_{CC}$ or GND; $I_D = 0$ A	1.65 – 4.5			1.0	μΑ
I <sub>NC (OFF)</sub> I <sub>NO (OFF)</sub>	NC or NO Leakage Current	V <sub>IS</sub> = 1.65 V to 4.5 V	4.5		±10	±100	nA
I <sub>COM (ON)</sub>	COM ON Leakage Current	V <sub>IS</sub> = 1.65 V to 4.5 V	4.5		±10	±100	nA
ON RESIS	TANCE (Typical: T = 25°C)						
R <sub>ON</sub>	Peak On–Resistance	$I_{ON} = 8 \text{ mA}$ $V_{IS} = 0 \text{ V to V}_{CC}$	1.65 2.7 3.3 4.2		15.4 10.8 9.5 8.5	23.2 12.4 11.0 9.9	Ω
R <sub>FLAT</sub>	On–Resistance Flatness	$I_{ON} = 8 \text{ mA}$ $V_{IS} = 0 \text{ V to V}_{CC}$	1.65 2.7 3.3 4.2		5.5 2.9 2.7 2.8	10.2 3.3 3.3 3.3	Ω
$\Delta R_{ON}$	Delta On-Resistance	$I_{ON} = 8 \text{ mA}$ $V_{IS} = 0 \text{ V to V}_{CC}$	1.65 2.7 3.3 4.2		0.3 0.3 0.3 0.3	0.35 0.35 0.35 0.35	Ω

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Table 4. AC FLECTRICAL CHARACTERISTICS

•				_	-40°C to +85°C		
Symbol	Parameter	Test Conditions	V <sub>CC</sub> (V)	Min	Тур	Max	Unit
TIMING/FR	EQUENCY (Typical: T = 2	$5^{\circ}$ C, $V_{CC}$ = 3.3 V, $R_{L}$ = 50 $Ω$ , $C_{L}$ =	35 pF, f = 1 MHz)				
t <sub>PD</sub>	Propagation Delay, A to Bn or Bn to A	(See Figures 4 and 5)	1.65 – 4.5			0.25	ns
t <sub>ON</sub>	Turn-ON Time	(See Figures 7 and 8)	1.65 – 4.5	3.1	13.0	30.0	ns
t <sub>OFF</sub>	Turn-OFF Time	(See Figures 7 and 8)	1.65 – 4.5	3.4	12.0	25.0	ns
T <sub>BBM</sub>	Break-Before-Make Time	(See Figure 6)	1.65 – 4.5	2.0			ns
BW	-3 dB Bandwidth	C <sub>L</sub> = 5 pF	1.65 – 4.5		1000		MHz
SOLATION	(Typical: T = 25°C, V <sub>CC</sub> =	3.3 V, $R_L = 50 \Omega$ , $C_L = 5 pF$ )					
O <sub>IRR</sub>	OFF-Isolation	f = 240 MHz (See Figure 9)	1.65 – 4.5		-21		dB
X <sub>TALK</sub>	Non-Adjacent Channel Crosstalk	f = 240 MHz	1.65 – 4.5		-21		dB

# **Table 4. AC ELECTRICAL CHARACTERISTICS**

CAPACITANCE (Typical: T = 25°C)

C <sub>IN</sub>	Control Pin	V <sub>CC</sub> = 0 V, f = 1 MHz	1.5	pF
	Input Capacitance	V <sub>CC</sub> = 0 V, f = 10 MHz	1.0	
C <sub>ON</sub>	ON Capacitance	V <sub>CC</sub> = 3.3 V; OE = 0 V, S = 0 V or 3.3 V, f = 1 MHz	7.5	
		V <sub>CC</sub> = 3.3 V; OE = 0 V, S = 0 V or 3.3 V, f = 10 MHz	6.5	
C <sub>OFF</sub>	OFF Capacitance	V <sub>CC</sub> = V <sub>IS</sub> = 3.3 V; OE = 0 V, S = 3.3 V or 0 V, f = 1 MHz	3.8	
		$V_{CC} = V_{IS} = 3.3 \text{ V}; \text{ OE} = 0 \text{ V}, \\ S = 3.3 \text{ V} \text{ or } 0 \text{ V}, \text{ f} = 10 \text{ MHz}$	2.0	

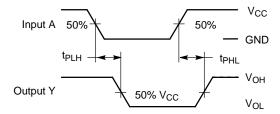
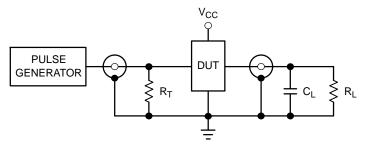


Figure 4. Propagation Delay Waveforms



 $R_T = Z_{OUT}$  of pulse generator (typically 50  $\Omega$ )

Figure 5. Propagation Delay Test Circuit

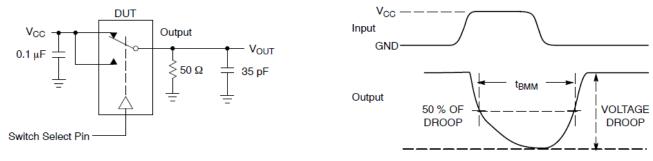


Figure 6. t<sub>BBM</sub> (Time Break-Before-Make)

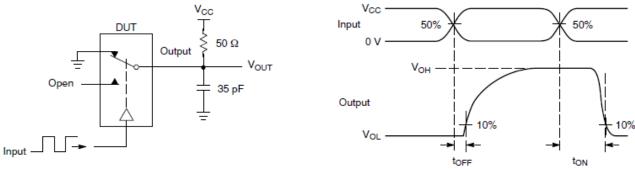


Figure 7. t<sub>ON</sub> / t<sub>OFF</sub>

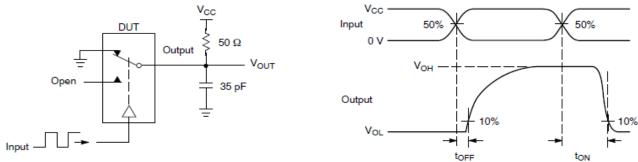
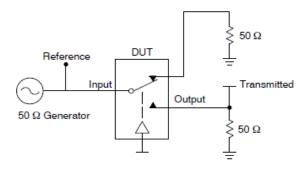


Figure 8.  $t_{ON}$  /  $t_{OFF}$ 



Channel switch control/s test socket is normalized. Off isolation is measured across an off channel. On loss is the bandwidth of an On switch.  $V_{\rm ISO}$ , Bandwidth and  $V_{\rm ONL}$  are independent of the input signal direction.

$$V_{ISO}$$
 = Off Channel Isolation = 20 Log $\left(\frac{V_{OUT}}{V_{IN}}\right)$  for  $V_{IN}$  at 100 kHz  $V_{ONL}$  = On Channel Loss = 20 Log $\left(\frac{V_{OUT}}{V_{IN}}\right)$  for  $V_{IN}$  at 100 kHz to 50 MHz

Bandwidth (BW) = the frequency 3 dB below VonL

 $V_{CT}$  = Use  $V_{ISO}$  setup and test to all other switch analog input/outputs terminated with 50  $\Omega$ 

Figure 9. Off Channel Isolation / On Channel Loss (BW)/Crosstalk (On Channel to Off Channel) / V<sub>ONL</sub>

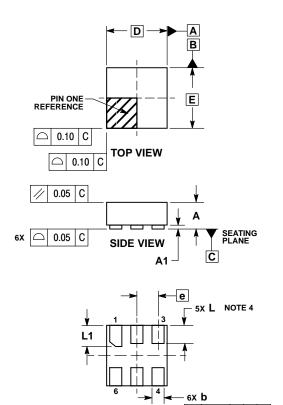
# ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NLAS3157MX3TCG	ULLGA6 - 1.0 x 1.0, 0.35P (Pb-Free)	3000 / Tape & Reel
NLAS3257CMX2TCG	XLLGA6 - 1.0 x 1.0, 0.35P	2000 / Tono & Book
NLAS3257CMX3TCG	(Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## **PACKAGE DIMENSIONS**

# ULLGA6 1.0x1.0, 0.35P CASE 613AD **ISSUE A**



**BOTTOM VIEW** 

0.10 | C | A | B |

0.05 C NOTE 3

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- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

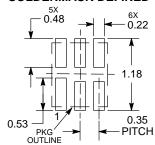
  2. CONTROLLING DIMENSION: MILLIMETERS.

  3. DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND
- AND 13 MEADONED BETWEEN 3.1 AND 0.30 mm FROM THE TERMINAL TIP.

  A MAXIMUM OF 0.05 PULL BACK OF THE PLATED TERMINAL FROM THE EDGE OF THE PACKAGE IS ALLOWED.

	MILLIMETERS				
DIM	MIN	MAX			
Α		0.40			
A1	0.00	0.00 0.05			
b	0.12 0.22				
D	1.00 BSC				
Е	1.00 BSC				
е	0.35 BSC				
L	0.25	0.35			
L1	0.30 0.40				

# **MOUNTING FOOTPRINT SOLDERMASK DEFINED\***

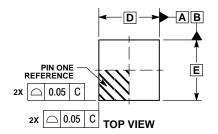


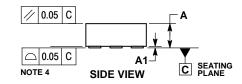
DIMENSIONS: MILLIMETERS

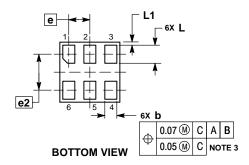
<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

# PACKAGE DIMENSIONS

# XLLGA6 1.0x1.0, 0.35P CASE 713AD **ISSUE O**



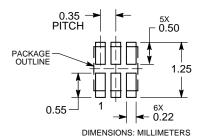




- DIMENSIONING AND TOLERANCING PER ASME
- CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION b APPLIES TO THE PLATED TERMINALS AND IS MEASURED BETWEEN 0.15 AND 0.25 MM FROM THE TERMINAL TIPS.
- 4. COPLANARITY APPLIES TO ALL OF THE TERMINALS.

	MILLIMETERS				
DIM	MIN	MAX			
Α		0.40			
A1	0.00	0.05			
b	0.17	0.17 0.23			
D	1.00	1.00 BSC			
E	1.00	1.00 BSC			
е	0.35	BSC			
e2	0.60	0.60 BSC			
L	0.27	0.27 0.33			
L1	0.05 REF				

#### RECOMMENDED **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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